





LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				ATTY. DOCKET NO.: 88265-7248		APPLICATION NO.: 10/661,432		
				APPLICANT: Zheng et al.				
				FILING DATE: September 11, 2003		GROUP: 1761		
<b>U.S. PATENT DOCUMENTS</b>								
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
WAW	AA	5,922,380	07/1999	Takahara et al.	A23C	009/14		
WAW	AB	5,888,562	03/1999	Hansen et al.	A23G	1/00		
WAW	AC	5,364,555	11/1994	Zenner et al.	252	188.28		
WAW	AD	4,897,273	01/1990	Koraki et al.	426	118		
WAW	AE	4,539,216	09/1985	Tse	426	597		
WAW	AF	4,287,995	09/1981	Moriya	215	228		
LAW	AG	3,482,987	12/1969	Pitchon et al.	426	460		
WAW	AH	2,892,718	06/1959	Irwin M. Stone	99	48		
WAW	AI	2001/0008647 A1	9/2001	Belrhilid et al	426	535		
<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
LAW	AJ	EP 0 277 688	01/1988	Europe			X	
WAW	AK	EP 0861596	09/1998	Europe			X	
WAW	AL	EP0328336	08/1989	Europe			X	
LAW	AM	WO 0069274	11/2000	PCT			X	
LAW	AN	WO9518540	07/1995	PCT			X	
LAW	AO	WO9611861	04/1996	PCT			X	
LAW	AP	08182486	07/1996	Japan (abstract)			X	
LAW	AQ	62278948	12/1987	Japan (abstract)			X	
LAW	AR	1109277	04/1995	China (abstract)			X	
LAW	AS	640241	07/1950	Great Britian			X	

<b>LIST OF REFERENCES CITED BY APPLICANT</b> <i>(Use several sheets if necessary)</i>				ATTY. DOCKET NO.:		APPLICATION SERIAL NO.:		
				88265-7248		10/001432		
				APPLICANT:				
				Ying Zheng et al.				
FILING DATE:				GROUP:				
<b>U.S. PATENT DOCUMENTS</b>								
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
UW	AA	3,421,906	1/1969	Ismar M. Reich et al.	99	152		
UW	AB	3,540,889	11/1970	William P. Clinton et al.	99	71		
UW	AC	4,378,380	3/1983	Scarpellino et al.	426	533		
UW	AD	2001/0008647	7/2001	Belrhld et al.	426	535		
<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
UW	AE	0 934 702	8/1999	EUROPE			X	
UW	AF	0 963 706	12/1999	EUROPE			X	
UW	AG	JP 8196212 (with English Abstract)	8/1996	JAPAN			X	
UW	AH	JP 2000-116364 (with English Abstract)	4/2000	JAPAN			X	
UW	AI	HU-44914 English Abstract	4/1986	HUNGARY			X	
UW	AJ	WO 02/087360	11/2002	PCT			X	
	AK							
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AL							
	AM							
	AN							
<b>EXAMINER</b>					<b>DATE CONSIDERED</b>			
Leslie Wang					6/9/04			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								



OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)		
	AT	Holscher, W. et al, XP008007644, "Investigations of Roasted Coffee Freshness With An Improved Headspace Technique-Aromafrische Mittles Einer Vergesserten Headspace-Methodik", Forschung, vol. 195, no. 1, 1992, pages 33-38
	AU	Semmelroch, P. et al., XP000602989 "Analysis of Roasted Coffee Powders And Brews By Gas Chromatography-Olfactometry of Headspace Samples" Lebensmittel Wissenschaft Und Technologies, vol. 28, no. 3, 1995, pages 310-313
EXAMINER		DATE CONSIDERED
Leslie Wong		6/9/04
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		